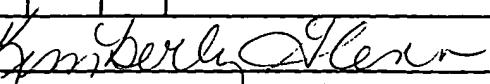


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Page 1 of 1

FORM PTO-1449 <u>INFORMATION DISCLOSURE STATEMENT</u>			ATTY. DOCKET NO. 1875.0610000		APPLICATION NO. 10/040,376		
			APPLICANT Gomez et al.				
			FILING DATE January 9, 2002		GROUP 2817		
			U. S. PATENT DOCUMENTS				
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
	AA1						
	AB1						
	AC1						
	AD1						
	AE1						
	AF1						
	AG1						
	AH1						
	AI1						
	AJ1						
	AK1						
FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION
	AL1						Yes No
	AM1						Yes No
	AN1						Yes No
	AO1						Yes No
	AP1						Yes No
OTHER (Including Author, Title, Date, Pertinent Pages, etc.)							
		AR	1	Matthaei, G. et al., <i>Microwave Filters, Impedance-Matching Networks, and Coupling Structures</i> , Artech House, Inc., entire book submitted (1980).			
		AS	1				
		AT	1				
EXAMINER 					DATE CONSIDERED 10/12/04		
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							



Page 1 of 1

FORM PTO-1449 <u>INFORMATION DISCLOSURE STATEMENT</u>			ATTY. DOCKET NO. 1875.0610000/JTH/LMY		APPLICATION NO. 10/040,376		
			APPLICANT Gomez et al.				
			FILING DATE January 9, 2002		GROUP 2817		
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
<i>CBK</i>		AA1 6,252,476 B1	06/2001	Maloratsky			
		AB1 6,448,640 B2	09/2002	Corisis			06/18/2001
		AC1					
		AD1					
		AE1					
		AF1					
		AG1					
		AH1					
		AI1					
		AJ1					
		AK1					
FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION
		AL1					Yes No
		AM1					Yes No
		AN1					Yes No
		AO1					Yes No
		AP1					Yes No
OTHER (Including Author, Title, Date, Pertinent Pages, etc.)							
	AR	1					
<i>CBK</i>	AS	1	Kuo, J.-T., et al., "Microstrip Elliptic Function Filters with Compact Miniaturized Hairpin Resonators," IEEE, pp. 861-864 (1999).				
	AT	1					
EXAMINER:	<i>Kimberly Kers</i>				DATE CONSIDERED <i>10/12/04</i>		
EXAMINER: Initial if reference considered whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							

FORM PTO-1449

APR 29 2004

SECOND SUPPLEMENTAL
INFORMATION DISCLOSURE STATEMENTATTY. DOCKET NO.
1875.0610000APPLICATION NO.
10/040,376

INVENTORS

Gomez et al.

FILING DATE

January 9, 2002

ART UNIT
2817

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
<i>JK</i>	AA1	4,418,324	11/1983	Higgins			
<i>JK</i>	AB1	5,955,931	09/1999	Kaneko et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION
<i>JK</i>	AJ1	0 506 476 A1	09/1992	EP			N/A
	AK1	5-308204 A	11/1993	JP			No
	AL1	8-65007 A	03/1996	JP			No
	AM1	11-317603 A	11/1999	JP			No

OTHER (Including Author, Title, Date, Pertinent Pages, etc.)

<i>JK</i>	AN	1	European Patent Office English-language Abstract for JP 05308204, published November 19, 1993, 1 page.
	AO	1	European Patent Office English-language Abstract for JP 08065007, published March 8, 1996, 1 page.
	AP	1	European Patent Office English-language Abstract for JP 11317603, published November 16, 1999, 1 page.
	AQ	1	European Search Report from European Patent Application No. 03250090.2, dated January 14, 2004, 3 pages.

EXAMINER	<i>Kimberly Glenn</i>	DATE CONSIDERED
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.		